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| Notice of References Cited | Application/Control No. 09/445,656 | Applicant(s)/Patent Under Reexamination KABANOV ET AL. | |
| | Examiner Helen Nguyen | Art Unit 1617 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification | |
|---|---|--|-----------------|-----------------|----------------|-------|
| | A | US-5,410,016 | 04-1995 | Hubbell et al. | 528 | 354 |
| | B | US-5,112,611 | 05-1992 | Ahmad et al. | 424 | 195.1 |
| | C | US-5,531,917 | 07-1996 | Nakayama et al. | 510 | 114 |
| | D | US-5,171,737 | 12-1992 | Weiner et al. | 514 | 3 |
| | E | US- | | | | |
| | F | US- | | | | |
| | G | US- | | | | |
| | H | US- | | | | |
| | I | US- | | | | |
| | J | US- | | | | |
| | K | US- | | | | |
| | L | US- | | | | |
| | M | US- | | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification | |
|---|---|--|-----------------|---------|------|----------------|--|
| | N | | | | | | |
| | O | | | | | | |
| | P | | | | | | |
| | Q | | | | | | |
| | R | | | | | | |
| | S | | | | | | |
| | T | | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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